

Notice of References Cited	Application/Control No. 10/574,383	Applicant(s)/Patent Under Reexamination AKASHI ET AL.	
	Examiner AMENE S. BAYOU	Art Unit 3746	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0191094	09-2004	Kojima et al.	417/415
	B	US-			
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NON-PATENT DOCUMENTS

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